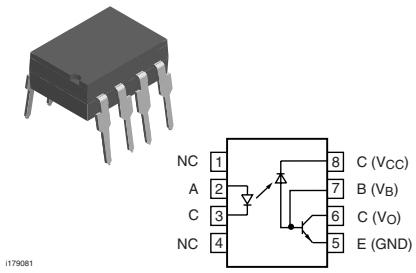
High Speed Optocoupler, 1 MBd, Photodiode with Transistor Output, 110 °C Rated



FEATURES

- Operating temperature from - 55 °C to + 110 °C
- Isolation test voltages: 5300 V_{RMS}
- TTL compatible
- High bit rates: 1.0 MBd
- Bandwidth 2.0 MHz
- Open-collector output
- External base wiring possible
- Lead (Pb)-free component
- Component in accordance to RoHS 2002/95/EC and WEEE 2002/96/EC

Pb-free

e3

RoHS COMPLIANT

DESCRIPTION

The 6N1135 and 6N1136 are 110 °C rated optocouplers with a GaAlAs infrared emitting diode, optically coupled with an integrated photo detector which consists of a photo diode and a high-speed transistor in a DIP-8 plastic package.
Signals can be transmitted between two electrically separated circuits up to frequencies of 2.0 MHz. The potential difference between the circuits to be coupled should not exceed the maximum permissible reference voltages.

AGENCY APPROVALS

- UL1577, file no. E52744 system code H or J
- DIN EN 60747-5-5
- CUL - file no. E52744, equivalent to CSA bulletin 5A

ORDER INFORMATION

PART	REMARKS
6N1135	CTR ≥ 7 %, DIP-8
6N1136	CTR ≥ 19 %, DIP-8
6N1135-X007	CTR ≥ 7 %, SMD-8 (option 7)
6N1136-X006	CTR ≥ 19 %, DIP-8 400 mil (option 6)
6N1136-X007	CTR ≥ 19 %, SMD-8 (option 7)
6N1136-X009	CTR ≥ 19 %, SMD-8 (option 9)

Note
For additional information on the available options refer to option information.

ABSOLUTE MAXIMUM RATINGS (1)

PARAMETER	TEST CONDITION	SYMBOL	VALUE	UNIT
INPUT				
Reverse voltage		V_R	5.0	V
Forward current		I_F	25	mA
Peak forward current	t = 1.0 ms, duty cycle 50 %	I_{FM}	50	mA
Maximum surge forward current	t ≤ 1.0 µs, 300 pulses/s	I_{FSM}	1.0	A
Thermal resistance		R_{th}	700	K/W
Power dissipation	T_{amb} = 70 °C	P_{diss}	45	mW
OUTPUT				
Supply voltage		V_{CC}	- 0.5 to 15	V
Output voltage		V_O	- 0.5 to 15	V
Emitter base voltage		V_{EBO}	5.0	V
Output current		I_O	8.0	mA
Maximum Output current			16	mA
Base current		I_B	5.0	mA
Thermal resistance			300	K/W
Power dissipation	T_{amb} = 70 °C	P_{diss}	100	mW

ABSOLUTE MAXIMUM RATINGS (1)

PARAMETER	TEST CONDITION	SYMBOL	VALUE	UNIT
COUPLER				
Isolation test voltage (between emitter and detector climate per DIN 50014 part 2, Nov. 74)	t = 1.0 s	V_{ISO}	5300	V_{RMS}
Storage temperature range		T_{stg}	- 55 to + 125	°C
Ambient temperature range		T_{amb}	- 55 to + 100	°C
Soldering temperature (2)	max. ≤ 10 s, dip soldering ≥ 0.5 mm from case bottom	T_{sld}	260	°C

Notes

(1) T_{amb} = 25 °C, unless otherwise specified.
Stresses in excess of the absolute maximum ratings can cause permanent damage to the device. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. Exposure to absolute maximum ratings for extended periods of the time can adversely affect reliability.

(2) Refer to reflow profile for soldering conditions for surface mounted devices (SMD). Refer to wave profile for soldering conditions for through hole devices (DIP).

ELECTRICAL CHARACTERISTICS

PARAMETER	TEST CONDITION	PART	SYMBOL	MIN.	TYP.	MAX.	UNIT
INPUT							
Forward voltage	I_F = 1.6 mA		V_F		1.6	1.9	V
Breakdown voltage	I_R = 10 µA		V_{BR}	5.0			V
Reverse current	V_R = 5.0 V		I_R		0.5	10	µA
Capacitance	V_R = 0 V, f = 1.0 MHz		C_I		125		pF
Temperature coefficient, forward voltage	I_F = 1.6 mA		$\Delta V_F/\Delta T_A$		- 1.7		mV/°C
OUTPUT							
Logic low supply current	I_F = 1.6 mA, V_O = open, V_{CC} = 15 V		I_{CCL}		150		µA
Logic high supply current	I_F = 0 mA, V_O = open, V_{CC} = 15 V		I_{CCH}		0.01	1	µA
Output voltage, output low	I_F = 16 mA, V_{CC} = 4.5 V, I_O = 1.1 mA,	6N1135	V_{OL}		0.1	0.4	V
	I_F = 16 mA, V_{CC} = 4.5 V, I_O = 2.4 mA,	6N1136	V_{OL}		0.1	0.4	V
Output current, output high	I_F = 0 mA, V_O = V_{CC} = 5.5 V		I_{OH}		3.0	500	nA
	I_F = 0 mA, V_O = V_{CC} = 15 V		I_{OH}		0.01	1	µA
COUPLER							
Capacitance (input to output)	f = 1.0 MHz		C_{IO}		0.6		pF
Current transfer ratio	I_F = 16 mA, V_O = 0.4 V, V_{CC} = 4.5 V	6N1135	CTR	7.0	16		%
		6N1136	CTR	19	35		%
	I_F = 16 mA, V_O = 0.5 V, V_{CC} = 4.5 V	6N1135	CTR	5.0			%
		6N1136	CTR	15			%

Note

T_{amb} = 25 °C, unless otherwise specified.
Minimum and maximum values are testing requirements. Typical values are characteristics of the device and are the result of engineering evaluation. Typical values are for information only and are not part of the testing requirements.

SWITCHING CHARACTERISTICS							
PARAMETER	**TEST CONDITION**	**PART**	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNIT**
High to low	I_F = 16 mA, V_{CC} = 5.0 V, R_L = 4.1 kΩ	6N1135	t_{PHL}		0.3	1.5	µs
	I_F = 16 mA, V_{CC} = 5.0 V, R_L = 1.9 kΩ	6N1136	t_{PHL}		0.2	0.8	µs
Low to high	I_F = 16 mA, V_{CC} = 5.0 V, R_L = 4.1 kΩ	6N1135	t_{PLH}		0.3	1.5	µs
	I_F = 16 mA, V_{CC} = 5.0 V, R_L = 1.9 kΩ	6N1136	t_{PLH}		0.2	0.8	µs

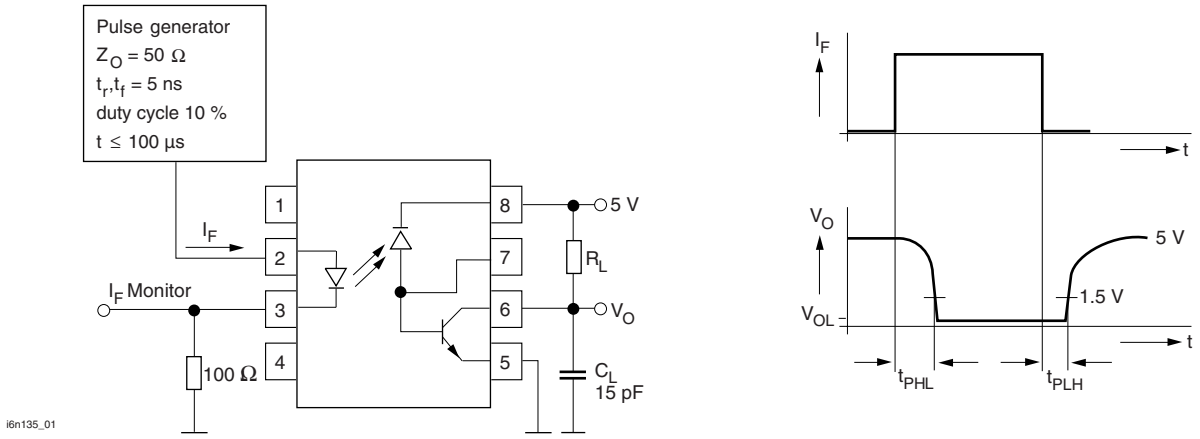


Fig. 1 - Switching Times

COMMON MODE TRANSIENT IMMUNITY							
PARAMETER	**TEST CONDITION**	**PART**	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNIT**
High	I_F = 0 mA, V_{CM} = 10 V_{P-P}, V_{CC} = 5.0 V, R_L = 4.1 kΩ	6N135	$\|CM_H\|$		1000		V/µs
	I_F = 0 mA, V_{CM} = 10 V_{P-P}, V_{CC} = 5.0 V, R_L = 1.9 kΩ	6N136	$\|CM_H\|$		1000		V/µs
Low	I_F = 16 mA, V_{CM} = 10 V_{P-P}, V_{CC} = 5.0 V, R_L = 4.1 kΩ	6N135	$\|CM_L\|$		1000		V/µs
	I_F = 16 mA, V_{CM} = 10 V_{P-P}, V_{CC} = 5.0 V, R_L = 1.9 kΩ	6N136	$\|CM_L\|$		1000		V/µs

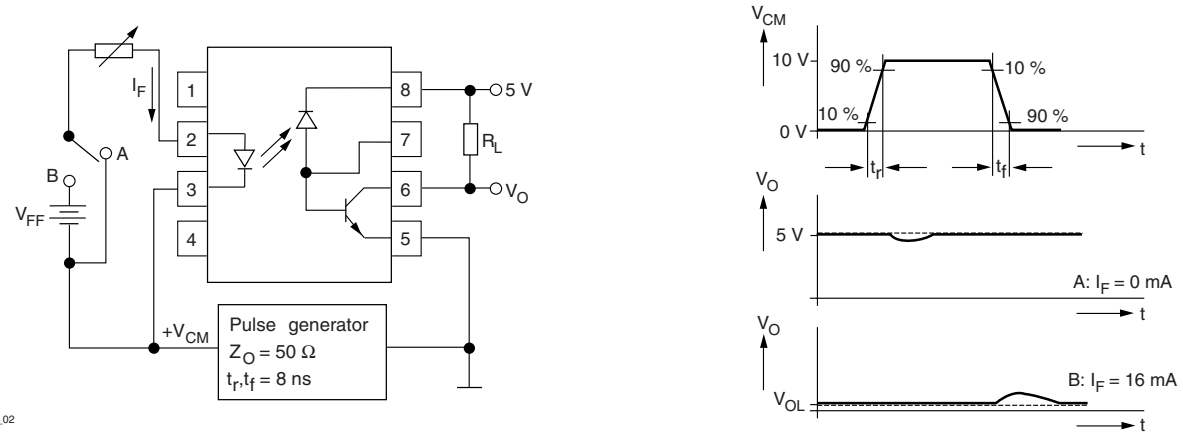


Fig. 2 - Common-Mode Interference Immunity

SAFETY AND INSULATION RATINGS						
PARAMETER	**TEST CONDITION**	**SYMBOL**	**MIN.**	**TYP.**	**MAX.**	**UNIT**
Climatic classification (according to IEC 68 part 1)				55/110/21		
Pollution degree (DIN VDE 0109)				2.0		
Comparative tracking index per DIN IEC112/VDE 0303 part 1, group IIIa per DIN VDE 6110		CTI	175		399	
V_{IOTM}		V_{IOTM}	8000			V
V_{IORM}		V_{IORM}	630			V
Isolation resistance	V_{IO} = 500 V, T_{amb} = 25 °C	R_{IO}	10^{12}			Ω
	V_{IO} = 500 V, T_{amb} = 100 °C	R_{IO}	10^{11}			Ω
P_{SI}		P_{SI}			500	mA
I_{SI}		I_{SI}			300	mW
T_{SI}		T_{SI}			175	°C
Creepage distance			7.0			mm
Clearance distance			7.0			mm
Insulation thickness			0.2			mm

Note

As per IEC 60747-5-2, § 7.4.3.8.1, this optocoupler is suitable for “safe electrical insulation” only within the safety ratings. Compliance with the safety ratings shall be ensured by means of protective circuits.

TYPICAL CHARACTERISTICS

T_{amb} = 25 °C, unless otherwise specified

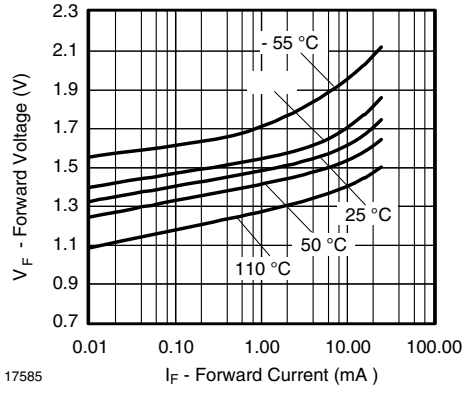


Fig. 3 - Forward Voltage vs. Forward Current

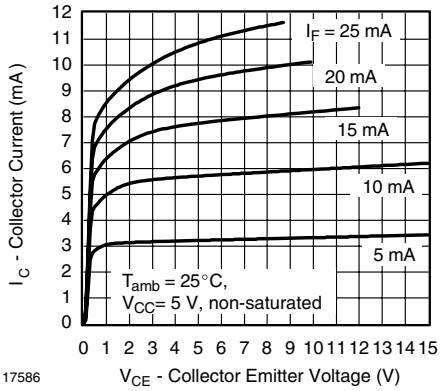


Fig. 4 - Collector Current vs. Collector Emitter Voltage

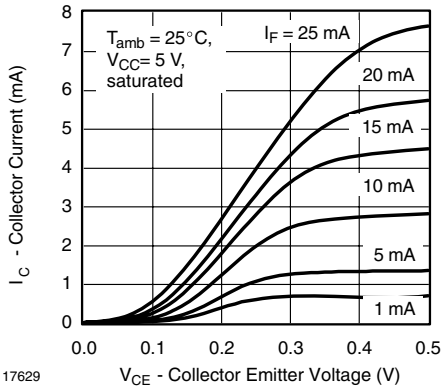


Fig. 5 - Collector Current vs. Collector Emitter Voltage

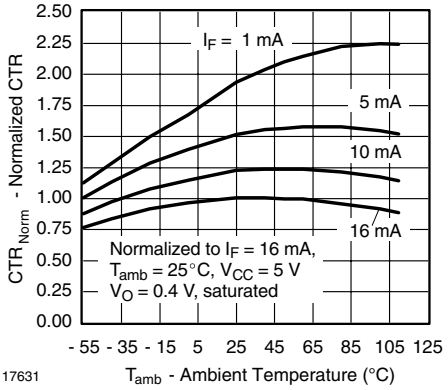


Fig. 8 - Normalized Current Transfer Ratio vs. Ambient Temperature

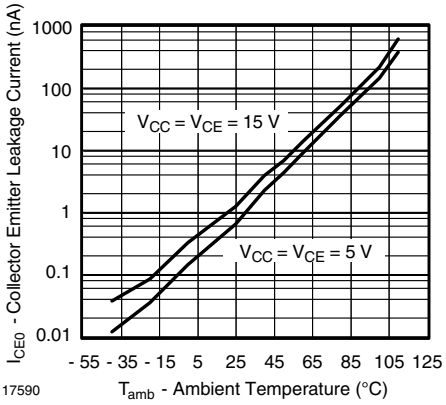


Fig. 6 - Collector Emitter Dark Current vs. Ambient Temperature

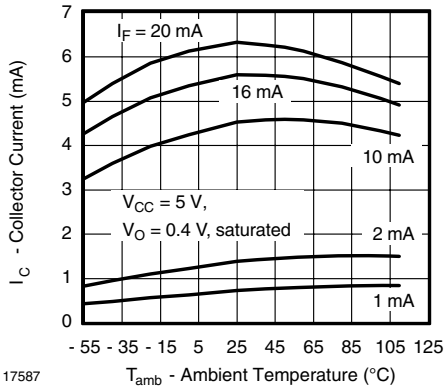


Fig. 9 - Output Current vs. Temperature

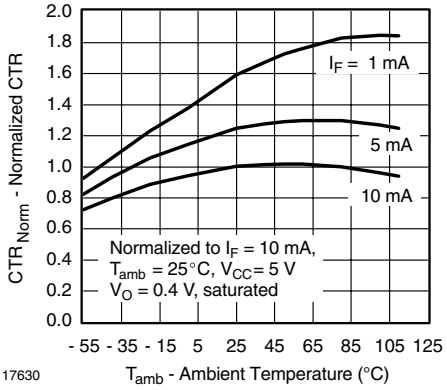


Fig. 7 - Normalized Current Transfer Ratio vs. Ambient Temperature

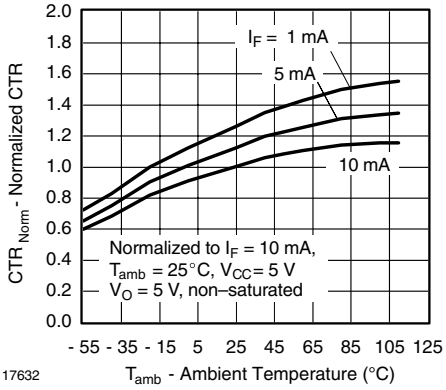


Fig. 10 - Normalized Current Transfer Ratio vs. Ambient Temperature

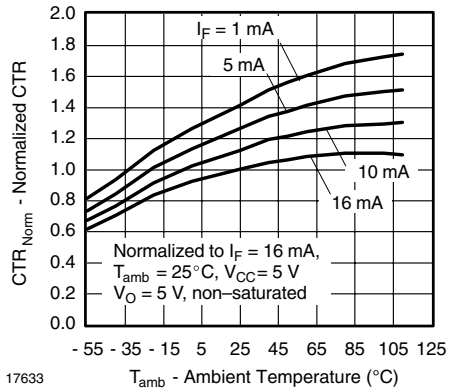


Fig. 11 - Normalized Current Transfer Ratio vs. Ambient Temperature

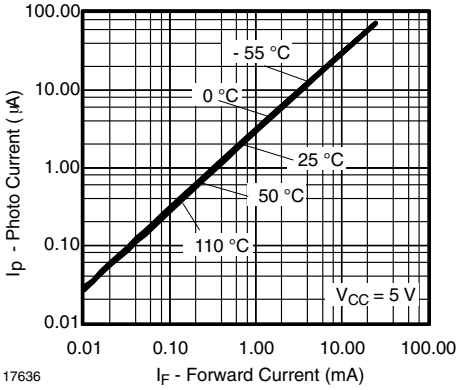


Fig. 14 - Photo Current vs. Forward Current

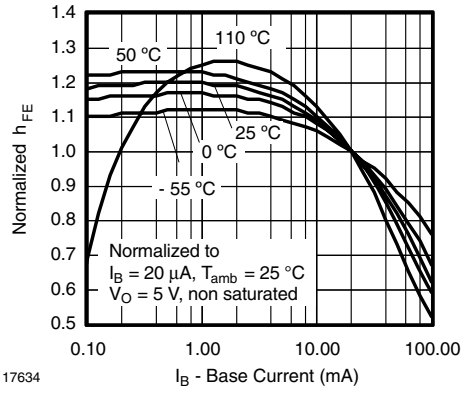


Fig. 12 - Normalized h_{FE} vs. Base Current

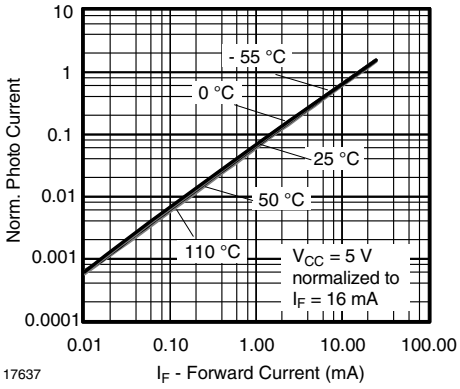


Fig. 15 - Photo Current vs. Forward Current

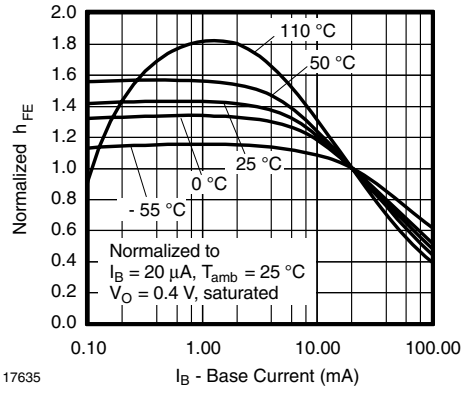


Fig. 13 - Normalized h_{FE} vs. Base Current

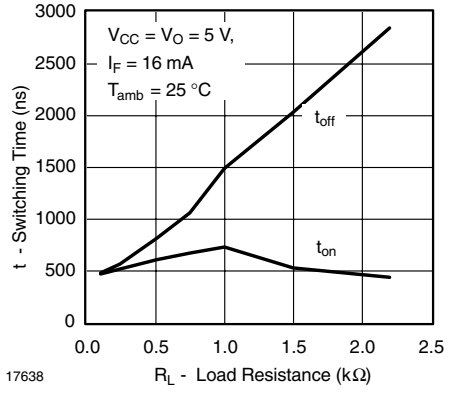


Fig. 16 - Switching Time vs. Load Resistance

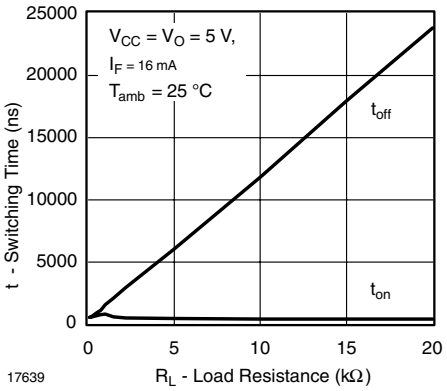


Fig. 17 - Switching Time vs. Load Resistance

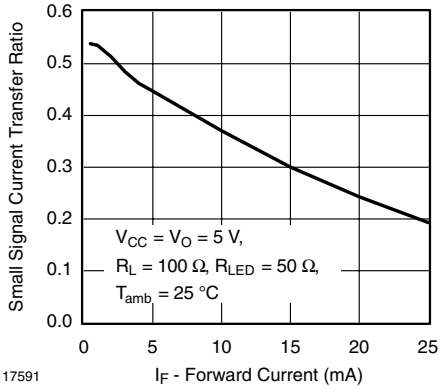


Fig. 20 - Small Signal CTR vs. Forward Current

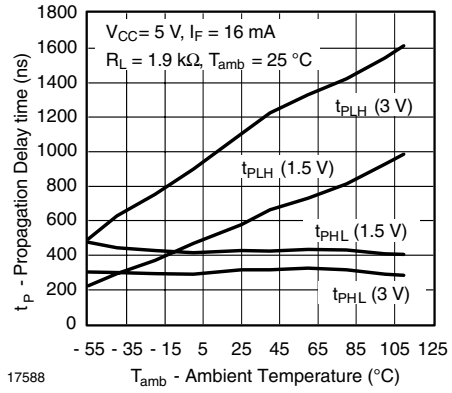


Fig. 18 - Propagation Delay vs. Ambient Temperature

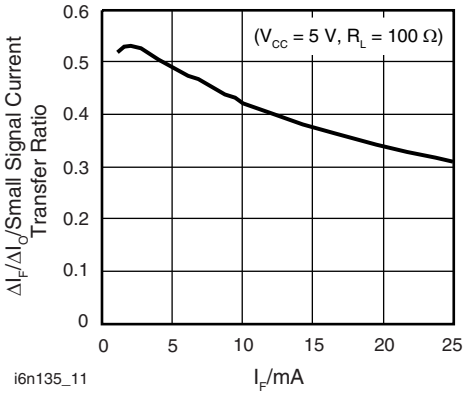


Fig. 21 - Small Signal Current Transfer Ratio vs. Quiescent Input Current

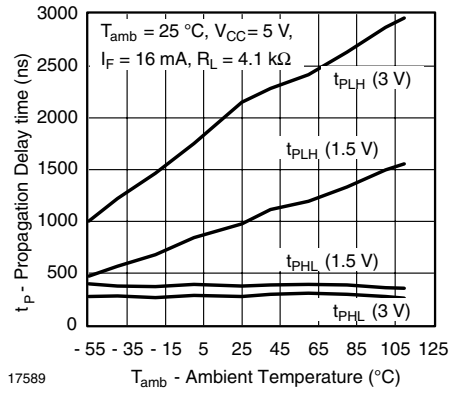
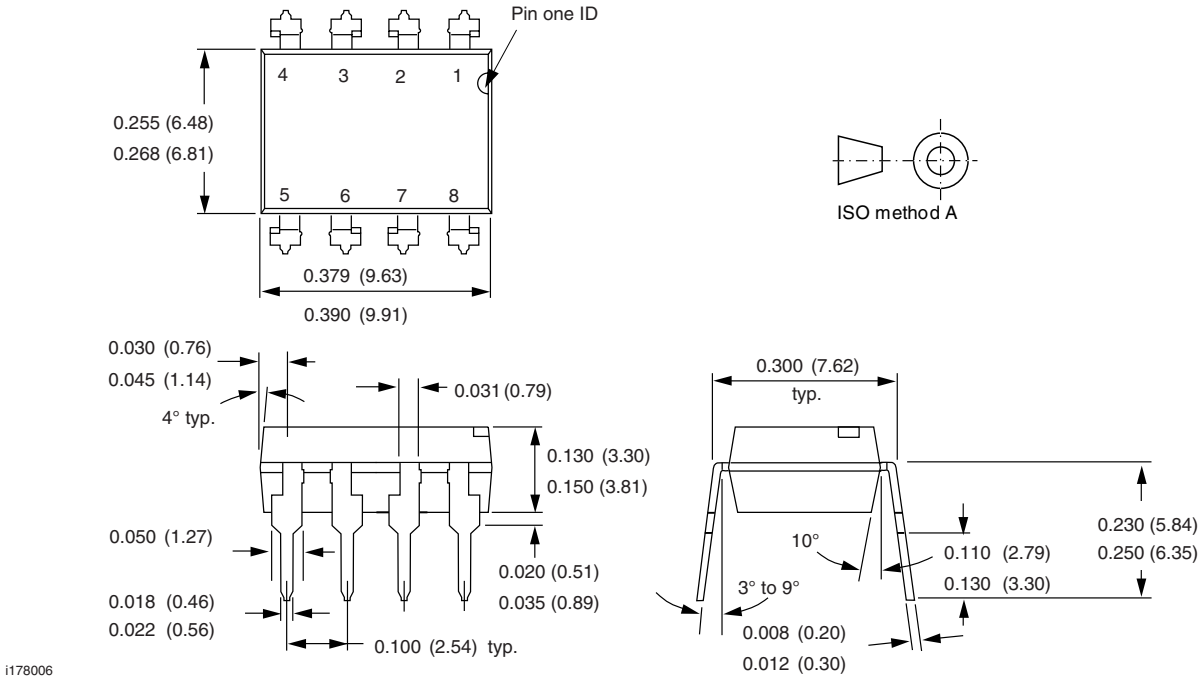
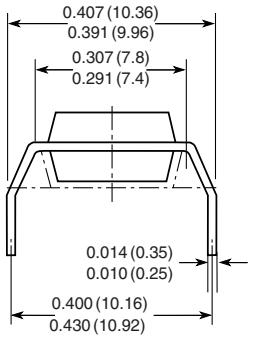


Fig. 19 - Propagation Delay vs. Ambient Temperature

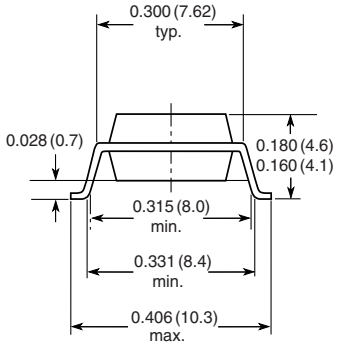
PACKAGE DIMENSIONS in inches (millimeters)



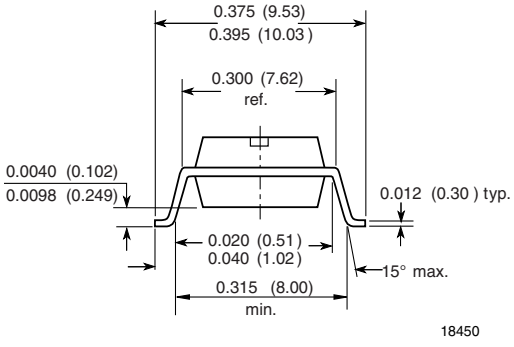
Option 6



Option 7



Option 9



OZONE DEPLETING SUBSTANCES POLICY STATEMENT

It is the policy of Vishay Semiconductor GmbH to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively.
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA.
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

Vishay Semiconductor GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany

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